Applicant(s)/Patent Under Application/Control No. Reexamination 09/202,216 ATARASHI ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 1615 Lakshmi S Channavajjala **U.S. PATENT DOCUMENTS** Date **Document Number** Classification Name Country Code-Number-Kind Code MM-YYYY US-Α US-В US-С US-D US-Е US-F US-G US-Н US-١ US-US-Κ US-L US-М FOREIGN PATENT DOCUMENTS **Document Number** Date Name Classification Country Country Code-Number-Kind Code MM-YYYY **SEKIN** JP 01247155 A 10-1989 **JAPAN** Ν 0 Ρ Q R s Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U ٧ W

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